

High voltage fast-switching NPN power transistor

Features

- STK13003 is reverse pin out versus standard SOT-82 package
- High voltage capability
- Low spread of dynamic parameters
- Minimum lot-to-lot spread for reliable operation
- Very high switching speed

Applications

- Electronic ballast for fluorescent lighting (CFL)
- SMPS for battery charger



The device is manufactured using high voltage multi-epitaxial planar technology for high switching speeds and high voltage capability.

It uses a cellular emitter structure with planar edge termination to enhance switching speeds while maintaining the wide RBSOA.

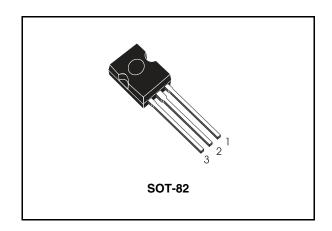


Figure 1. Internal schematic diagram

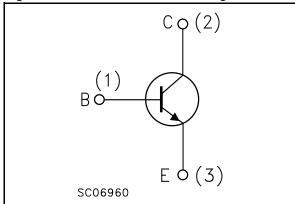


Table 1. Device summary

Order code	Marking	Package	Packaging
STK13003	K13003	SOT-82	Tube

Electrical ratings STK13003

1 Electrical ratings

Table 2. Absolute maximum rating

Symbol	Parameter	Value	Unit
V _{CES}	Collector-emitter voltage (V _{BE} = 0)	700	V
V _{CEO}	Collector-emitter voltage (I _B = 0)	400	V
V _{EBO}	Emitter-base voltage ($I_C = 0$, $I_B = 0.75A$, $tp < 10\mu s$)	V _{(BR)EBO}	V
I _C	Collector current	1.5	Α
I _{CM}	Collector peak current (t _P < 5ms)	3	Α
I _B	Base current	0.75	Α
I _{BM}	Base peak current (t _P < 5ms)	1.5	Α
P _{tot}	Total dissipation at T _c = 25°C	40	W
T _{stg}	Storage temperature	-55 to 150	°C
TJ	Max. operating junction temperature	150	°C

2 Electrical characteristics

 $(T_{case} = 25 \, ^{\circ}C \text{ unless otherwise specified})$

Table 3. Electrical characteristics

Symbol	Parameter	Test conditions		Min.	Тур.	Max.	Unit
I _{CES}	Collector cut-off current	V _{CE} =700V	T 10500			1	mA
	(V _{BE} = 0)	V _{CE} =700V	I _c = 125°C			5	mA
V _{(BR)EBO}	Emitter-Base breakdown voltage (I _C = 0)	I _E =10mA		9		18	٧
V _{CEO(sus)} (1)	Collector-emitter sustaining voltage (I _B = 0)	I _C =10mA		400			٧
	0 11 1	$I_{C} = 0.5A$	$I_B = 0.1A$			0.5	٧
V _{CE(sat)} (1)	Collector-emitter saturation voltage	I _C = 1A	$I_{B} = 0.25A$			1	V
		$I_{C} = 1.5A$	$I_{B} = 0.5A$			1.5	V
v (1)	Base-emitter saturation	I _C = 0.5A	I _B = 0.1A			1	٧
V _{BE(sat)} (1)	voltage	I _C = 1A	$I_{B} = 0.25A$			1.2	V
h _{FE}	DC current gain	I _C =0.5A	V _{CE} =2V	8		20	
		I _C =1A	$V_{CE} = 2V$	5		25	
	Resistive load	V _{CC} = 125V	lo = 1A				
t _r	Rise time	I _{B1} = 0.2A	-			1	μs
t_s	Storage time		1B20.2A			4	μs
t _f	Fall time	$T_p = 25\mu s$				0.7	μs
		I _C = 1A	$I_{B1} = 0.2A$				
t _s	Inductive load	V _{BE} =-5V	L=50mH		0.8		μs
	Storage time	V _{Clamp} =300V	′				

^{1.} Pulsed duration = 300 μs , duty cycle \leq 1.5%.

Electrical characteristics STK13003

2.1 Electrical characteristics (curves)

2.2

Figure 2. Safe operating areas

Figure 3. Derating curves

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T_C (°C)

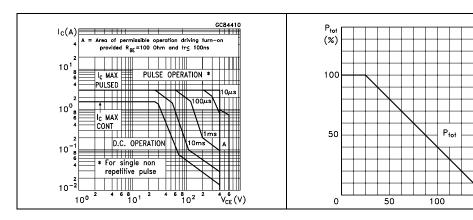


Figure 4. Output characteristics

Figure 5. Reverse biased safe operating areas

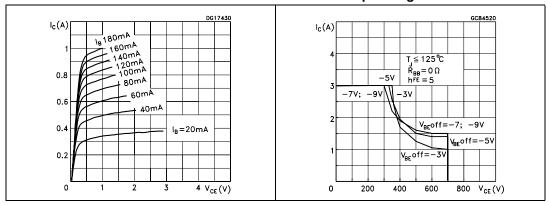


Figure 6. DC current gain

Figure 7. DC current gain

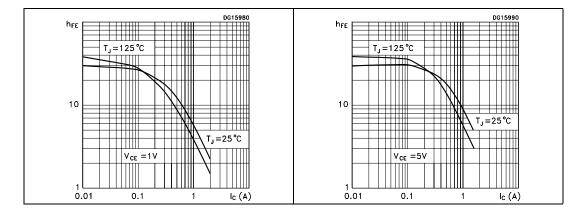


Figure 8. Collector-emitter saturation Figure 9. Base-emitter saturation voltage voltage

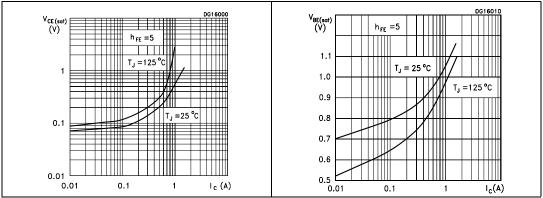
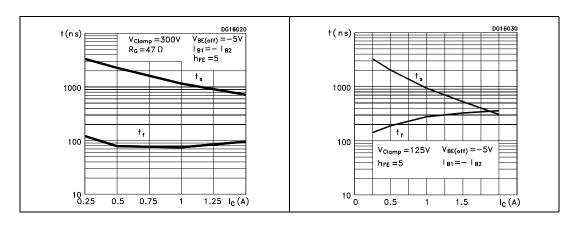
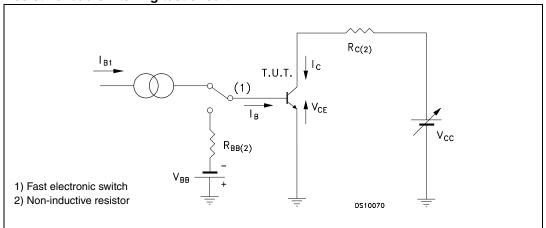


Figure 10. Inductive load switching time Figure 11. Resistive load switching time



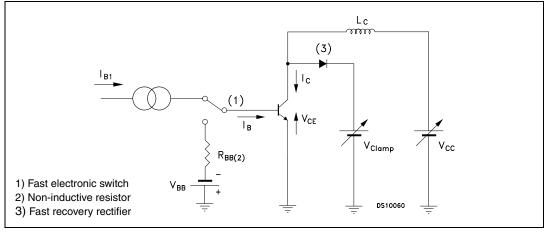
2.3 Test circuits

Resistive load switching test circuit



Electrical characteristics STK13003

Figure 12. Inductive load switching test circuit

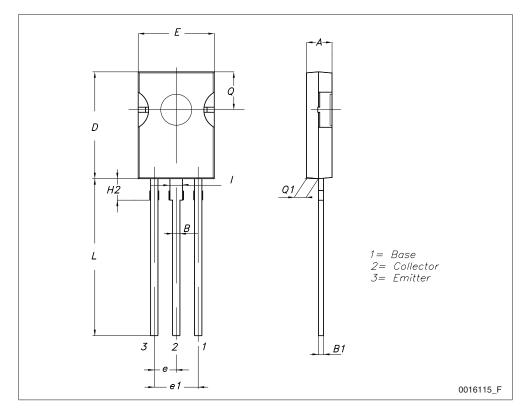


3 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

SOT-82 me	chanica	l data
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Dim.	mm.				
	Min.	Тур.	Max.		
A	2.40		2.70		
В	0.70		0.90		
B1	0.49		0.75		
D	10.50		10.80		
E	7.40		7.80		
е	2.04		2.54		
e1	4.07		5.08		
L	15.40		16		
Q		3.80			
Q1	1		1.30		
H2		2.07			
I		1.27			



STK13003 Revision history

4 Revision history

Table 4. Document revision history

Date	Revision	Changes
21-Jun-2004	3	
14-Jul-2008	4	Modified mechanical data Figure on page 8.

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